

DATE OF ISSUE : 2008. 02. 12

SPECIFICATION

MODEL : SLHNNWH531T0

HIGH POWER LED - SUNNIX

CUSTOMER : _____

SAMSUNG ELECTRO-MECHANICS		
DRAWN	CHECKED	APPROVED

CUSTOMER		
CHECKED	CHECKED	APPROVED

SAMSUNG ELECTRO-MECHANICS CO.,LTD.
314, MAETAN3-DONG, YEONGTONG-GU,
SUWON, GYUNGGI-DO, KOREA,442-743

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Product Outline

1) Feature

1. Plastic Molded L/Frame type (7.0mm * 7.0mm * t 4.8mm)
2. Beam Angle ($\Delta\theta : 55^\circ$)
3. High Power/Brightness Chip & Long Time Reliability

2) Applications

- Automotive, Illumination etc.

Absolute Maximum Rating

- Operation Forward Current 700 mA
- Peak Pulsed Forward Current 800 mA
(Duty 1/10 Pulse Width 10msec)
- Reverse Voltage 5V
- Thermal Resistance(Rth)²⁾ $\cong 8^\circ\text{C/W}$
- LED Junction Temperature (T_j) 125°C
- Operating Temperature Range (T_{opr}) -35°C ~ 85°C
- Storage Temperature Range (T_{stg}) -40°C ~ 110°C

Characteristics^{1),2)}

Electrical Characteristics

(T_j : 25°C)

Item	Rank	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward Voltage	S0	VF	3.2	-	4.5	V	IF=700mA
Reverse Voltage	-	VR	0.5	-	2.0	V	IR=10mA

Chromaticity Coordinate

Rank	CCx				CCy				CCT [K]	Condition
P0	0.2712	0.2913	0.3128	0.3011	0.3064	0.2645	0.2864	0.3407	7,000~10,000	IF=700mA
Q0	0.3128	0.3250	0.3200	0.3011	0.2864	0.2981	0.3600	0.3407	6,000~7,000	
R0	0.3250	0.3428	0.3484	0.3200	0.2981	0.3138	0.3885	0.3600	5,000~6,000	
S0	0.3428	0.3700	0.3919	0.3484	0.3138	0.3322	0.4190	0.3885	4,000~5,000	

Luminous Flux

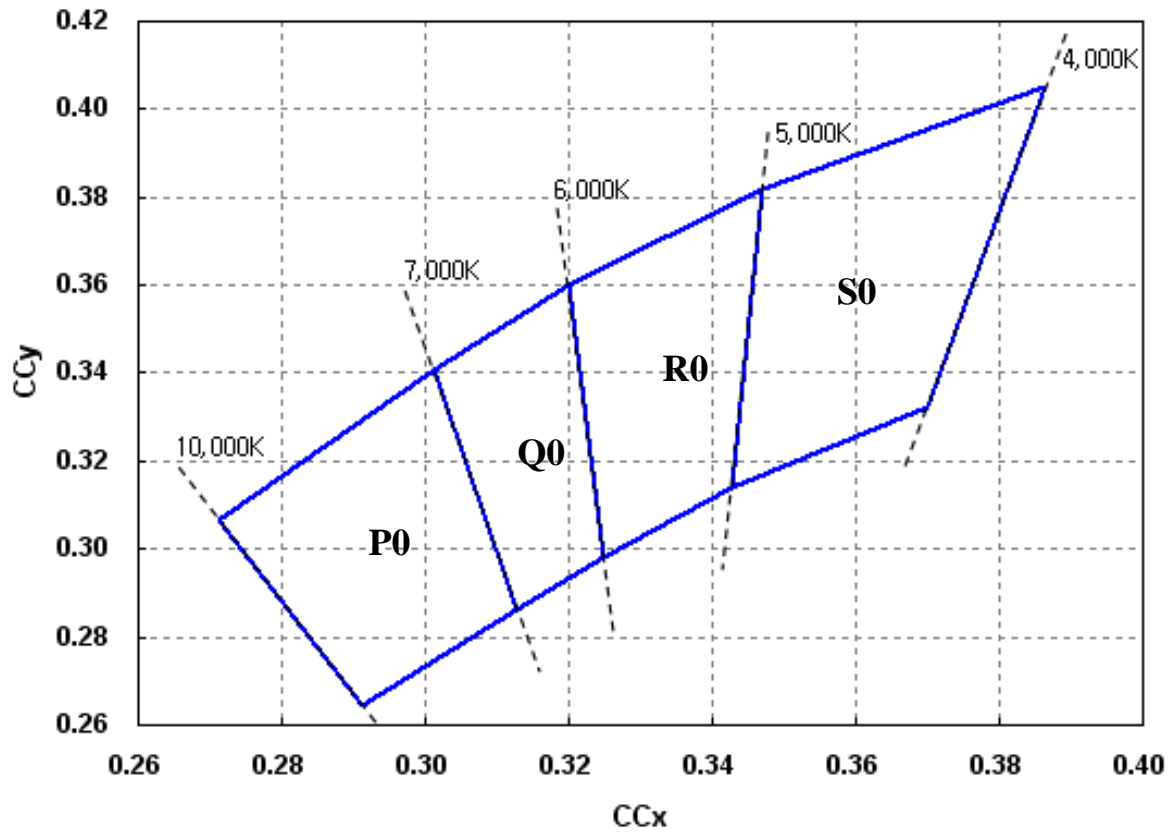
Rank	Symbol	Min.	Max.	Unit	Conditions
C5	F2	100	120	lm	IF=700mA
	G2	120	140		
	H2	140	160		

Remarks)

1) Tolerance : V_F : ± 0.1 , Φ_v : $\pm 10\%$, CCx CCy : ± 0.02

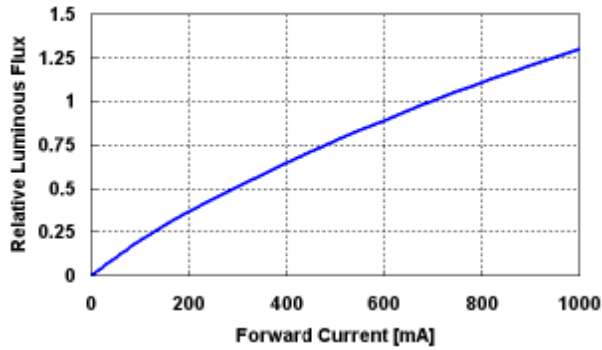
2) Proper thermal managements should be considered into a circuit design

■ Chromaticity Diagram

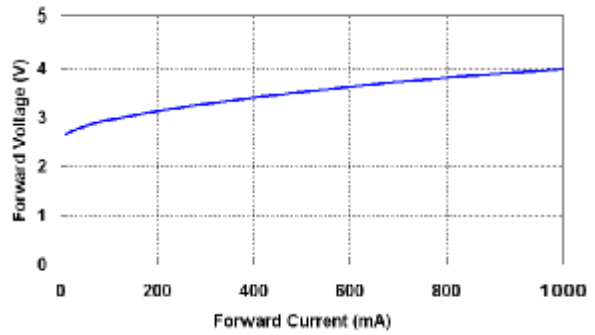


Typical Characteristics Graph

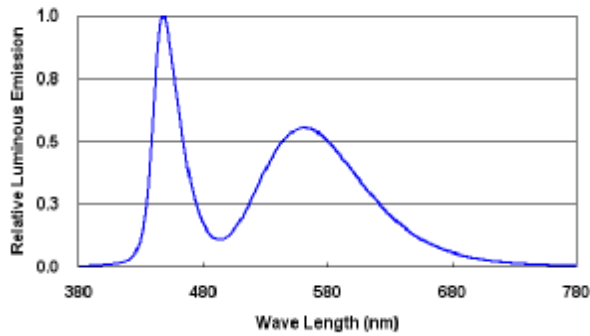
Relative Luminous Flux vs Forward Current



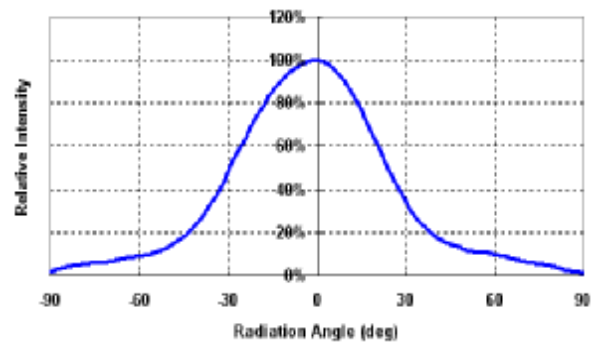
Forward Current vs Forward Voltage



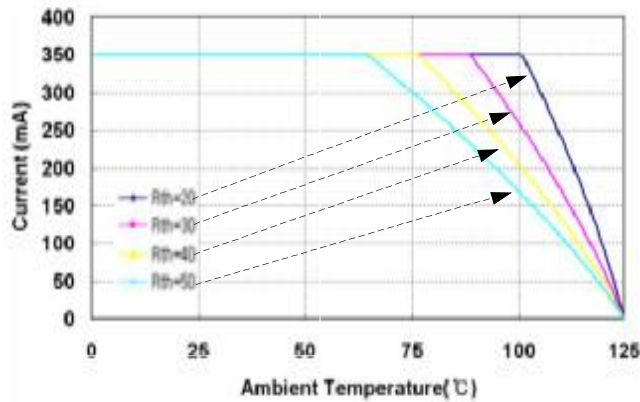
Spectrum Distribution



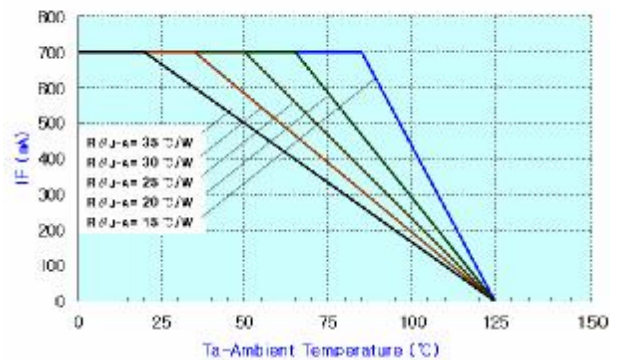
Radiation Diagram



Derating Curve for 350mA



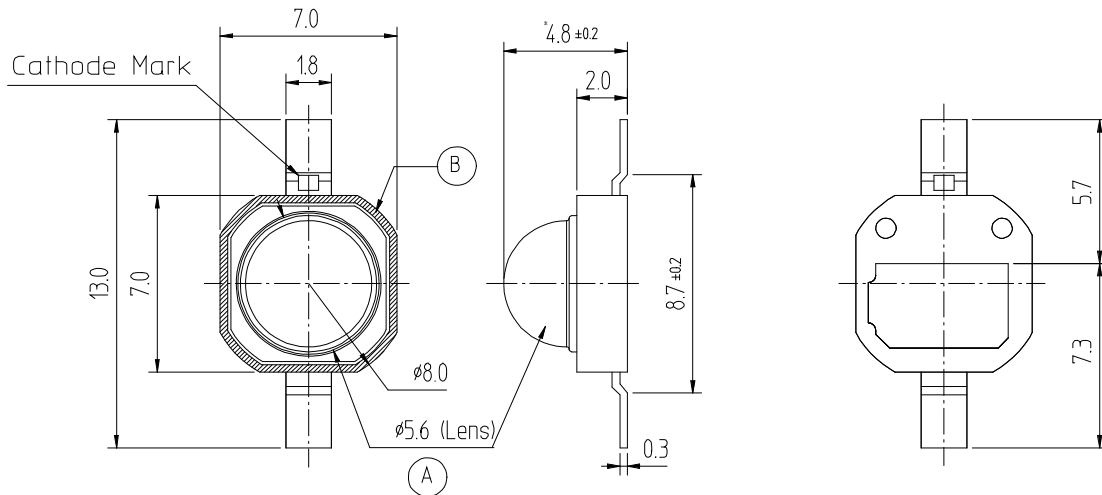
Derating Curve for 700mA (White)



Outline Drawing and Dimension

Unit:mm

Tolerance : ± 0.1



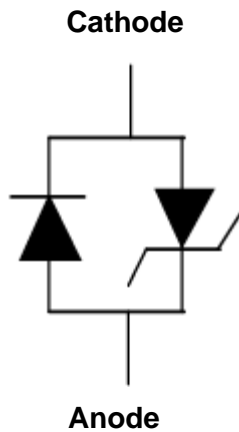
Pick and Place

1. Do not place pressure on the encapsulating resin ("A").

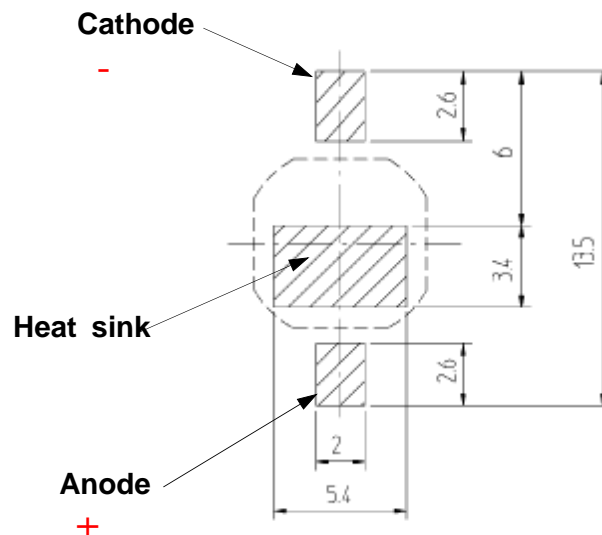
It is recommended to use a pick & place nozzle with inside diameter of 5.8mm.

2. The maximum compressing force is 15N on the polymer("B").

Circuit



Solder Pattern for Surface Mount

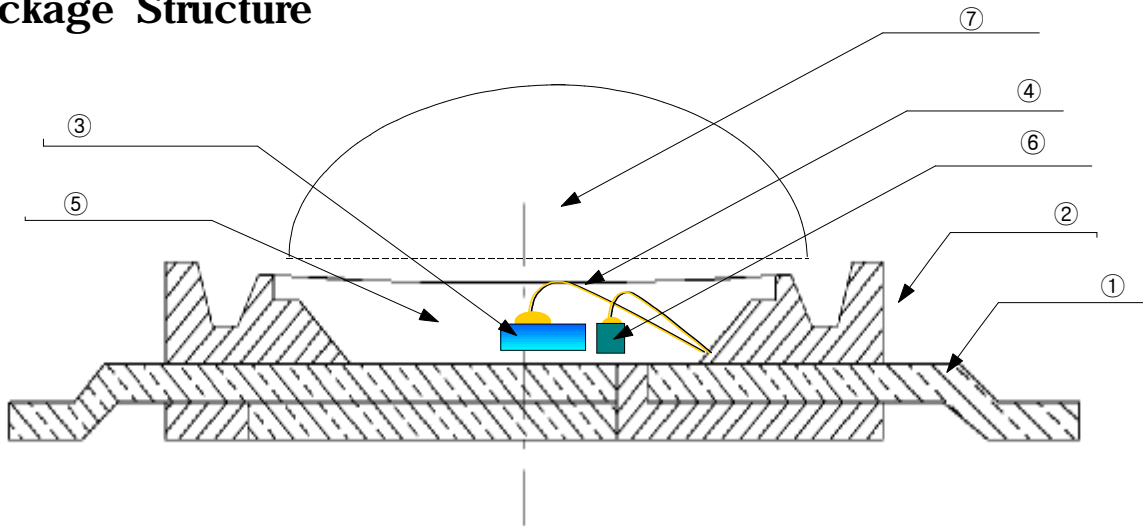


Remarks)

Make sure the heat sink is electrically connected to the Anode.

Heat sink is to be soldered, If not, use the heat conductive adhesive

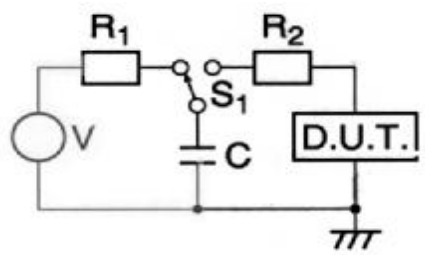
Package Structure



No	Item	Material
①	FRAME	Copper Frame(Silver plated)
②	PACKAGE	Heat- resistant Polymer
③	LED CHIP	SiC
④	WIRE	Gold Wire
⑤	RESIN	Silicone Resin (with phosphor)
⑥	ZENER DIODE	Si
⑦	LENS	Silicone Resin

■ Reliability Test Items and Conditions

1) Test Items

Test Item	Test Conditions	Test Hours/Cycles	Sample No
Room Temperature life test	25 °C, If=Max DC¹⁾	1,000 h	22
High Temperature humidity life test	85 °C, 85 % RH, If=Max DC¹⁾	1,000 h	22
High Temperature life test	85 °C, If=Max DC¹⁾	1,000 h	22
Low Temperature life test	-40 °C, If=Max DC¹⁾	1,000 h	22
High Temperature Storage	110 °C	1,000 h	11
Low Temperature Storage	-40 °C	1,000 h	11
Thermal Shock	-40 / 120 °C, each 30 min	200 cycles	22
Temperature humidity Cycle On/Off test	-40 / 85 °C, each 20 min, 100 min transfer Power On/off each 5 min, DC 350 mA	100 cycles	22
Reflow (Pb-Free)	Peak 260±5 °C for 10sec	3 times	11
ESD(HBM)	 <p style="text-align: center;">R1:10MΩ , R2:1.5KΩ , C:100pF</p>	3 times (± 5kV)	5

1) Max. DC current depending on maximum current derating curve.

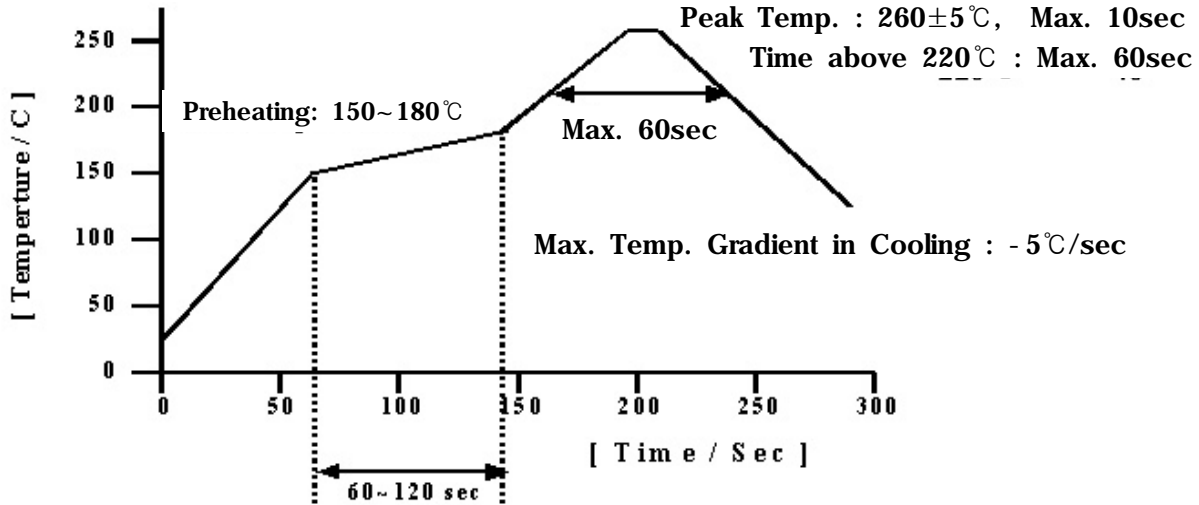
2) Criteria for Judging the Damage

Item	Symbol	Test Condition	Limit	
			Min	Max
Forward Voltage	VF	IF = 700 mA	-	U.S.L.*1.2
Luminous Flux	Φv	IF = 700 mA	L.S.L.*0.5	-

* USL : Upper Standard Level LSL : Lower Standard Level

■ Solder Conditions

Reflow Frequency : 2 times max.



2) For Manual Soldering

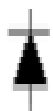
Not more than 5 seconds @MAX 300°C , under soldering iron.

■ Taping Dimension

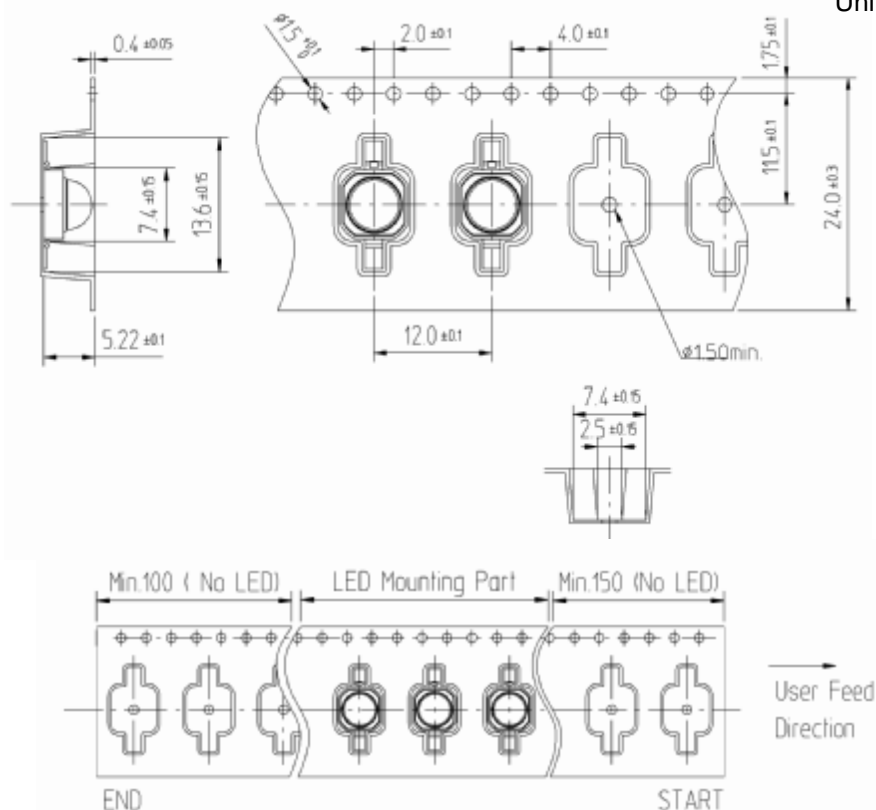
Unit : mm

1. Carrier Tape

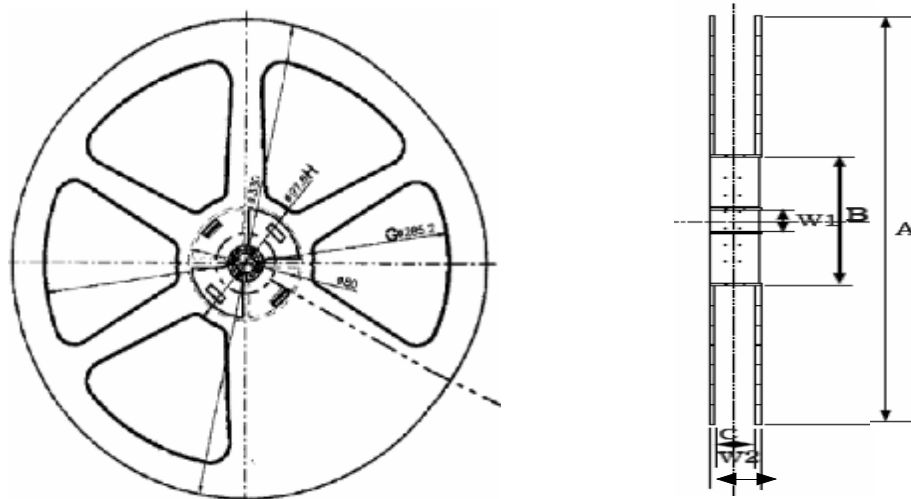
Cathode



Anode



2. Reel



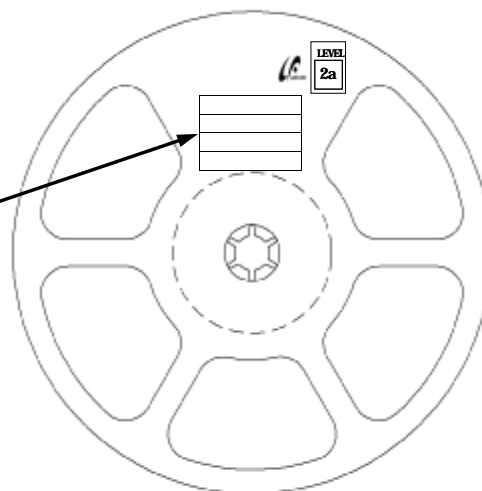
Symbol	A	B	C	W1	W2
Dimension(mm)	330 ± 1	80 ± 1	25 ± 0.5	13 ± 0.3	29.5 ± 1

- (1) Quantity : 1,000 Pcs / 13" Reel.
- (2) Cumulative Tolerance : Cumulative Tolerance/10 pitches to be $\pm 0.2\text{mm}$
- (3) Adhesion Strength of Cover Tape : Adhesion strength to be 0.1-0.7N when the cover tape is turned off from the carrier tape at 10°C angle to be the carrier tape.
- (4) Packaging : P/N, Manufacturing data Code No. and quantity to be indicated on a damp proof Package

Reel Packing Structure

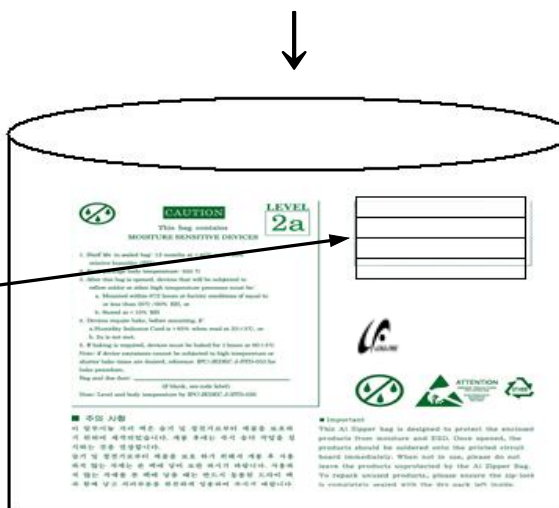
1) Reel

S0R0G2
 SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxxx / xxxx / xxxxpcs
 |||



2) Aluminum Vinyl Bag

S0R0G2
 SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxxx / xxxx / xxxxpcs
 |||

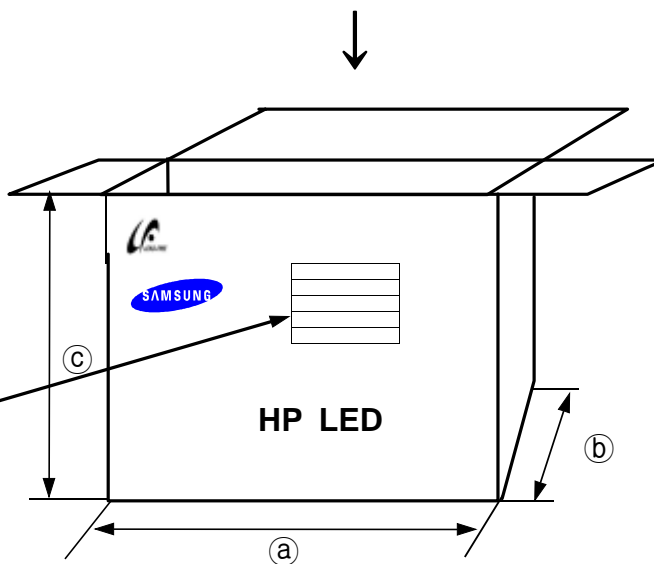


3) Inner Box

Material : Paper(SW3B(B))

TYPE	SIZE(mm)		
	a	b	c
13inch	335	45	335

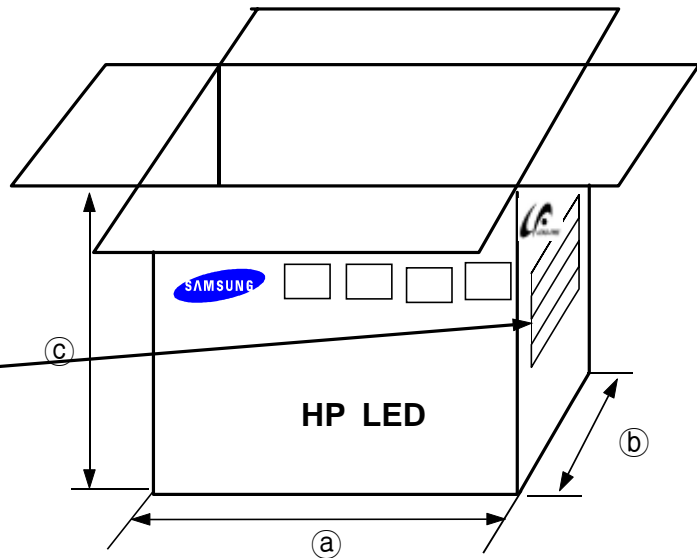
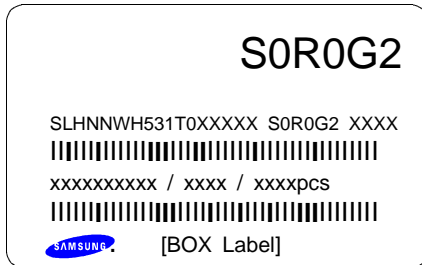
S0R0G2
 SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxxx / xxxx / xxxxpcs
 |||



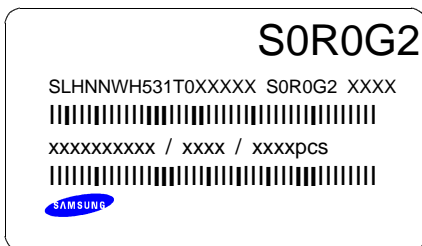
4) Carton Box

Material : Paper(SW3B(B))

TYPE	SIZE(mm)		
	(a)	(b)	(c)
13inch	350	350	350



Label Structure



(S0): VF Rank

(R0): Chromaticity Coordinate Rank(CCT)

(G2): Luminous Flux

Lot Number

The Lot number is composed of the following characters

●◎◇◆□■△△△ / I▲▲▲ / 1000PCS

● : Production Site (S:SEMCO, G:Gosin China)

◎ : L (LED)

◇ : Product State (A:Normality, B: Bulk, C:First Production, R:reproduction, S:Sample)


◆ : Year (Q:2006, R:2007, S:2008...)

□ : Month (1 ~ 9, A, B, C)

■ : Day (1 ~ 9, A, B ~ V)

△ : SEMCo. Product number (1 ~ 999)

▲ : Reel Number (1 ~ 999)



CAUTION

This bag contains
MOISTURE SENSITIVE DEVICES

LEVEL 2a

1. Shelf life in sealed bag: 12 months at <math>< 40^{\circ}\text{C}</math> and <math>< 90\%</math> relative humidity (RH)
2. Peak package body temperature: 240°C
3. After this bag is opened, devices that will be subjected to reflow solder or other high temperature processes must be:
 - a. Mounted within 672 hours at factory conditions of equal to or less than 30°C / 60% RH, or
 - b. Stored at <math>< 10\%</math> RH
4. Devices require bake, before mounting, if:
 - a. Humidity Indicator Card is > 65% when read at $23 \pm 5^{\circ}\text{C}$, or
 - b. 2a is not met.
5. If baking is required, devices must be baked for 1 hours at $60 \pm 5^{\circ}\text{C}$


Note: if device containers cannot be subjected to high temperature or shorter bake times are desired, reference IPC/JEDEC J-STD-033 for bake procedure.

Bag seal due date: _____
(if blank, see code label)

Note: Level and body temperature by IPC/JEDEC J-STD-020

S0R0G2

SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxx / xxx / xxxpcs
 |||




■ 주의 사항

이 알루미늄 지퍼 백은 습기 및 정전기로부터 제품을 보호하기 위하여 제작되었습니다. 개봉 후에는 즉시 솔더 작업을 실시하는 것을 권장합니다.

습기 및 정전기로부터 제품을 보호 하기 위해서 개봉 후 사용하지 않는 자재는 본 팩에 넣어 보관 하시기 바랍니다. 사용하지 않는 자재를 본 팩에 넣을 때는 반드시 동봉된 드라이 팩과 함께 넣고 지퍼부분을 완전히 밀봉하여 주시기 바랍니다.

■ Important

This Al Zipper bag is designed to protect the enclosed products from moisture and ESD. Once opened, the products should be soldered onto the printed circuit board immediately. When not in use, please do not leave the products unprotected by the Al Zipper Bag. To repack unused products, please ensure the zip-lock is completely sealed with the dry pack left inside.

Silical gel & Humidity Indicator Card in Aluminum Vinyl Bag



■ Precaution for Use

- 1) For over-current-proof function, customers are recommended to apply resistors to prevent sudden change of the current caused by slight shift of the voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When washing is required, IPA is recommended to use.
- 3) When the LEDs illuminate, operating current should be decided after considering the ambient maximum temperature.
- 4) LEDs must be stored in a clean environment.
If the LEDs are to be stored for 3 months or more after being shipped from SEMCO, they should be packed by a sealed container with nitrogen gas injected. (Shelf life of sealed bags : 12 months, temp. 0~40°C, 20~70%RH)
- 5) After storage bag is open, device subjected to soldering, solder reflow, or other high temperature processes must be:
 - a. Mounted within 168 hours (7 days) at an assembly line with a condition of no more than 30°C/60%RH,
 - b. Stored at <10% RH.
- 6) Repack unused Products with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading is >65% at 23±5°C.
- 8) Devices must be baked for 24hours at 65±5°C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs.

If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices.

Damaged LEDs may show some unusual characteristics such as increase in leak current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.

Hazard Substance Analysis



Test Report No. F690501/LF-CTSAYA08-04156

Issued Date: February 11, 2008 Page 1 of 3

To: **SAMSUNG ELECTRO-MECHANICS CO., LTD.**
314, Maetan3-dong
Yeongtong-gu
Suwon-city
GYEONGGI-DO 442-373
Korea

The following merchandise was submitted and identified by the client as :

Product Name : LED
SGS File No. : AYA08-04156
Received Date : February 04, 2008
Test Performing Date : February 05, 2008
Test Performed : SGS Testing Korea tested the sample(s) selected by applicant with following results
Test Results : For further details, please refer to following page(s)
Comments : The sampling and testing was performed only for the part indicated in the photo without disassembly by the applicant's specific request.

Pluto Kim
Monet Jeong
Billy Oh / Testing Person

SGS Testing Korea Co. Ltd.

Jeff Jang / Chemical Lab Mgr



Test Report No. F690501/LF-CTSAYA08-04156

Issued Date: February 11, 2008 Page 2 of 3

Sample No. : AYA08-04156.001
 Sample Description : LED
 Item No./Part No. : 7070 Lens (Cool White)

Heavy Metals

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	0.5	N.D.
Lead (Pb)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	5	N.D.
Mercury (Hg)	mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP	2	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	US EPA 3060A(1996), US EPA 7196A(1992), UV	1	N.D.

Flame Retardants-PBBs/PBDEs

Test Items	Unit	Test Method	MDL	Results
Monobromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Monobromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.

- NOTE: (1) N.D. = Not detected.(< MDL)
 (2) mg/kg = ppm
 (3) MDL = Method Detection Limit
 (4) - = No regulation
 (5) ** = Qualitative analysis (No Unit)
 (6) Negative = Undetectable / Positive = Detectable

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Test Report No. F890501/LF-CTSAYA08-04156

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Picture of Sample as Received:

Sample Color : Yellow



*** End ***

- NOTE:
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 - (2) mg/kg = ppm
 - (3) MDL = Method Detection Limit
 - (4) - = No regulation
 - (5) ** = Qualitative analysis (No Unit)
 - (6) Negative = Undetectable / Positive = Detectable

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2. Beam Angle ($\Delta\theta : 55^\circ$)
3. High Power/Brightness Chip & Long Time Reliability

2) Applications

- Automotive, Illumination etc.

Absolute Maximum Rating

- Operation Forward Current 700 mA
- Peak Pulsed Forward Current 800 mA
(Duty 1/10 Pulse Width 10msec)
- Reverse Voltage 5V
- Thermal Resistance(Rth)²⁾ $\cong 8^\circ\text{C/W}$
- LED Junction Temperature (T_j) 125°C
- Operating Temperature Range (T_{opr}) -35°C ~ 85°C
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Characteristics^{1),2)}

Electrical Characteristics

(T_j : 25°C)

Item	Rank	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward Voltage	S0	VF	3.2	-	4.5	V	IF=700mA
Reverse Voltage	-	VR	0.5	-	2.0	V	IR=10mA

Chromaticity Coordinate

Rank	CCx				CCy				CCT [K]	Condition
P0	0.2712	0.2913	0.3128	0.3011	0.3064	0.2645	0.2864	0.3407	7,000~10,000	IF=700mA
Q0	0.3128	0.3250	0.3200	0.3011	0.2864	0.2981	0.3600	0.3407	6,000~7,000	
R0	0.3250	0.3428	0.3484	0.3200	0.2981	0.3138	0.3885	0.3600	5,000~6,000	
S0	0.3428	0.3700	0.3919	0.3484	0.3138	0.3322	0.4190	0.3885	4,000~5,000	

Luminous Flux

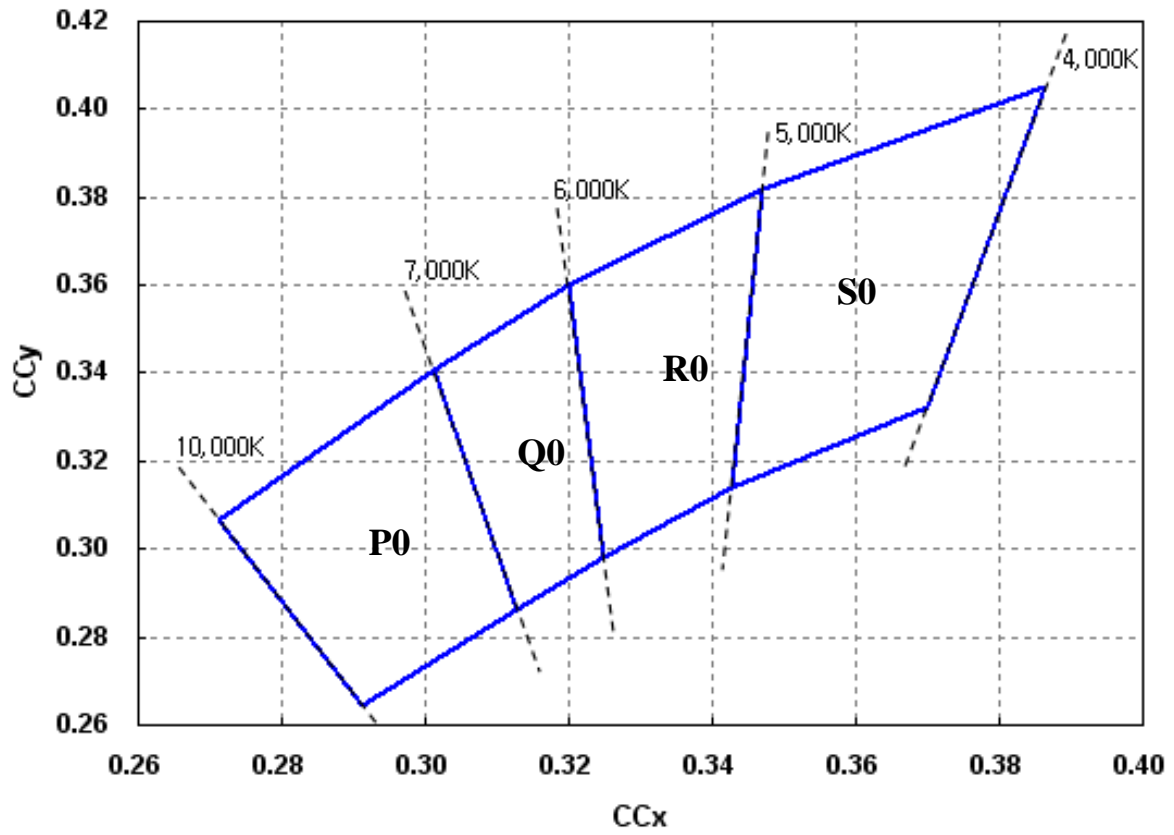
Rank		Symbol	Min.	Max.	Unit	Conditions
C5	F2	Φ_v	100	120	lm	IF=700mA
	G2		120	140		
	H2		140	160		

Remarks)

1) Tolerance : V_F : ± 0.1 , Φ_v : $\pm 10\%$, CCx CCy : ± 0.02

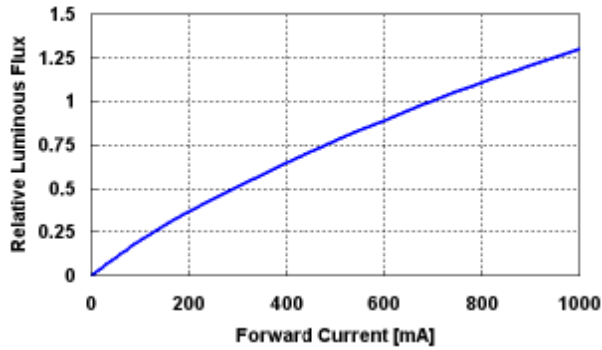
2) Proper thermal managements should be considered into a circuit design

■ Chromaticity Diagram

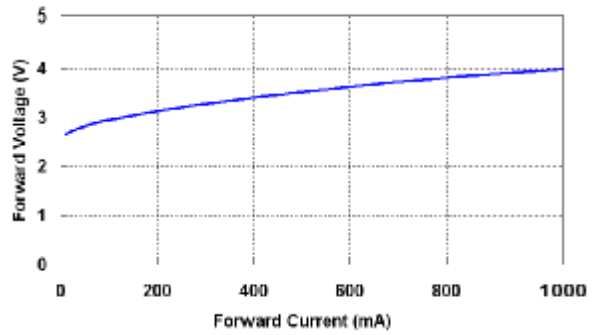


Typical Characteristics Graph

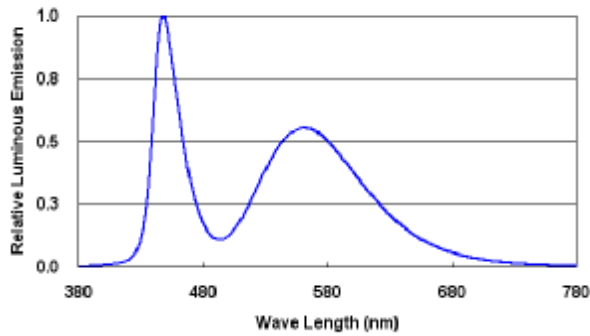
Relative Luminous Flux vs Forward Current



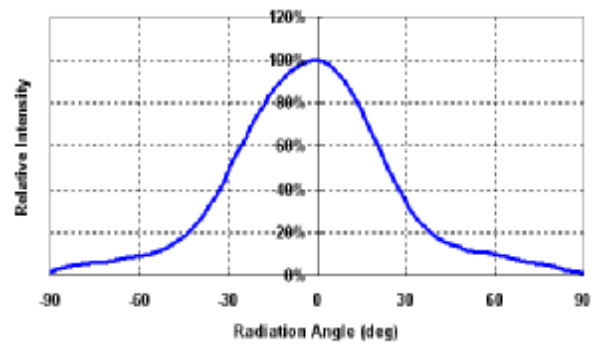
Forward Current vs Forward Voltage



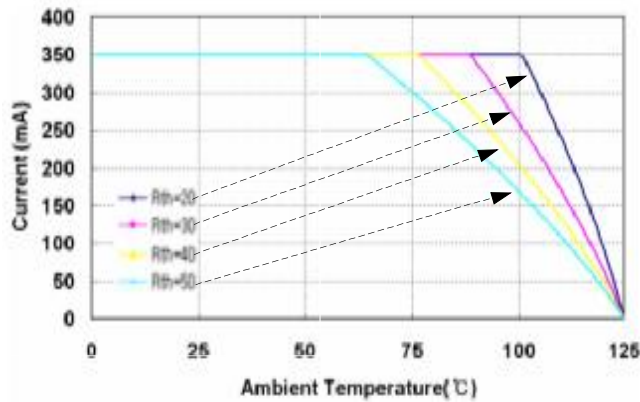
Spectrum Distribution



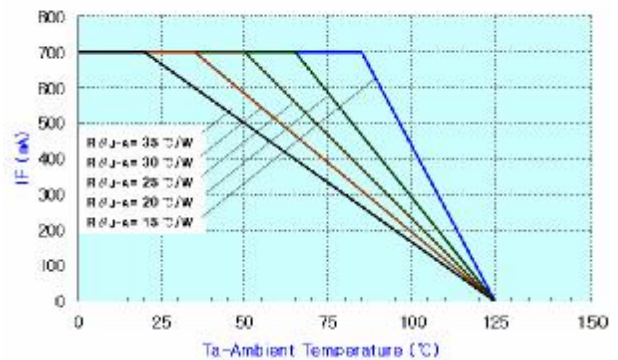
Radiation Diagram



Derating Curve for 350mA



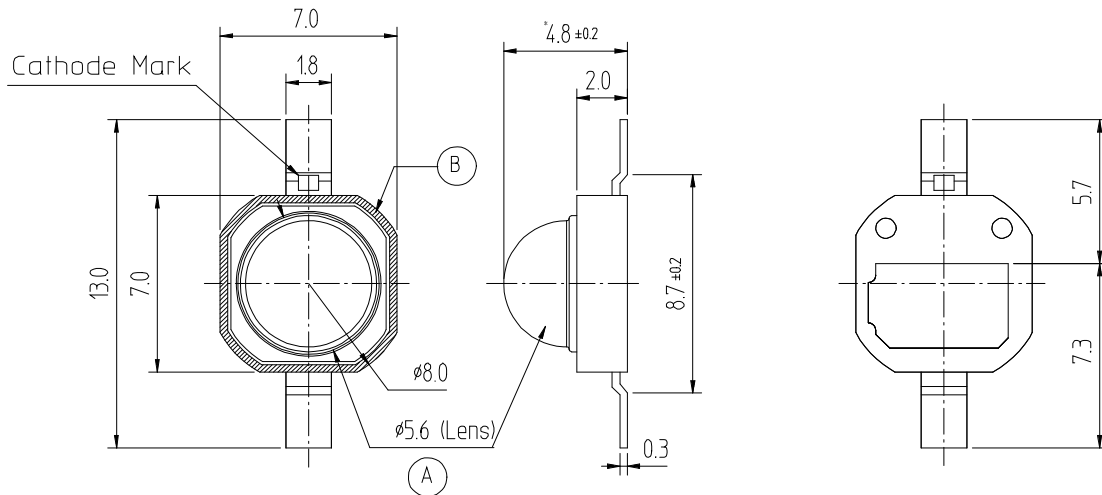
Derating Curve for 700mA (White)



Outline Drawing and Dimension

Unit:mm

Tolerance : ± 0.1



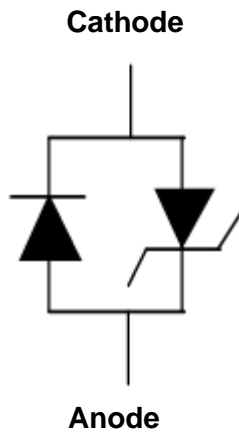
Pick and Place

1. Do not place pressure on the encapsulating resin ("A").

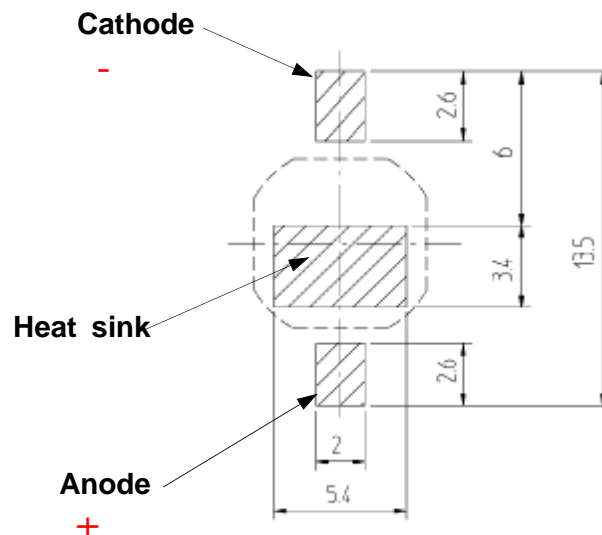
It is recommended to use a pick & place nozzle with inside diameter of 5.8mm.

2. The maximum compressing force is 15N on the polymer("B").

Circuit



Solder Pattern for Surface Mount

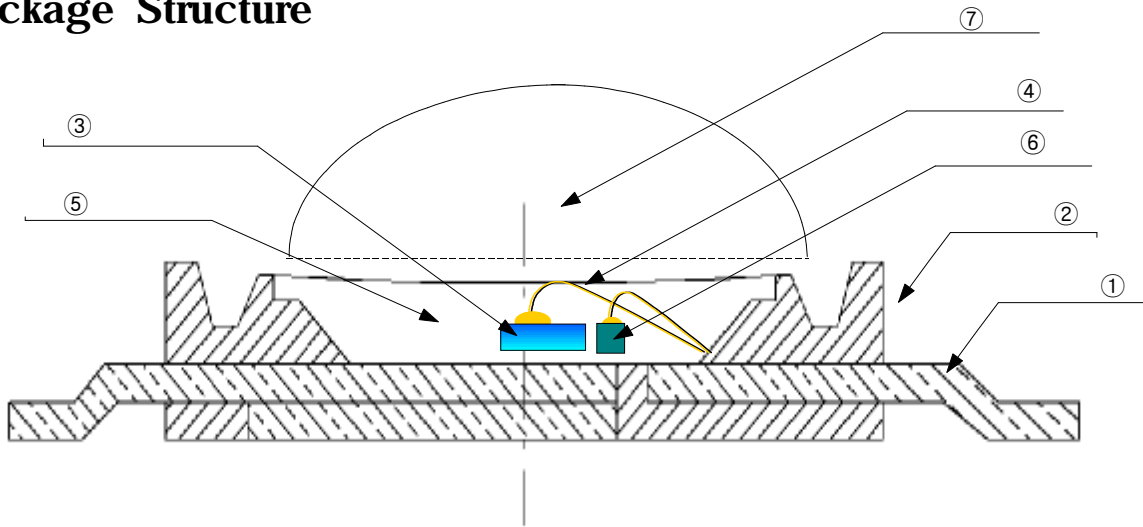


Remarks)

Make sure the heat sink is electrically connected to the Anode.

Heat sink is to be soldered, If not, use the heat conductive adhesive

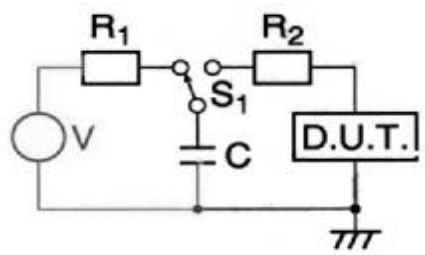
Package Structure



No	Item	Material
①	FRAME	Copper Frame(Silver plated)
②	PACKAGE	Heat- resistant Polymer
③	LED CHIP	SiC
④	WIRE	Gold Wire
⑤	RESIN	Silicone Resin (with phosphor)
⑥	ZENER DIODE	Si
⑦	LENS	Silicone Resin

■ Reliability Test Items and Conditions

1) Test Items

Test Item	Test Conditions	Test Hours/Cycles	Sample No
Room Temperature life test	25 °C, If=Max DC¹⁾	1,000 h	22
High Temperature humidity life test	85 °C, 85 % RH, If=Max DC¹⁾	1,000 h	22
High Temperature life test	85 °C, If=Max DC¹⁾	1,000 h	22
Low Temperature life test	-40 °C, If=Max DC¹⁾	1,000 h	22
High Temperature Storage	110 °C	1,000 h	11
Low Temperature Storage	-40 °C	1,000 h	11
Thermal Shock	-40 / 120 °C, each 30 min	200 cycles	22
Temperature humidity Cycle On/Off test	-40 / 85 °C, each 20 min, 100 min transfer Power On/off each 5 min, DC 350 mA	100 cycles	22
Reflow (Pb-Free)	Peak 260±5 °C for 10sec	3 times	11
ESD(HBM)	 <p style="text-align: center;">R1:10MΩ , R2:1.5KΩ , C:100pF</p>	3 times (± 5kV)	5

1) Max. DC current depending on maximum current derating curve.

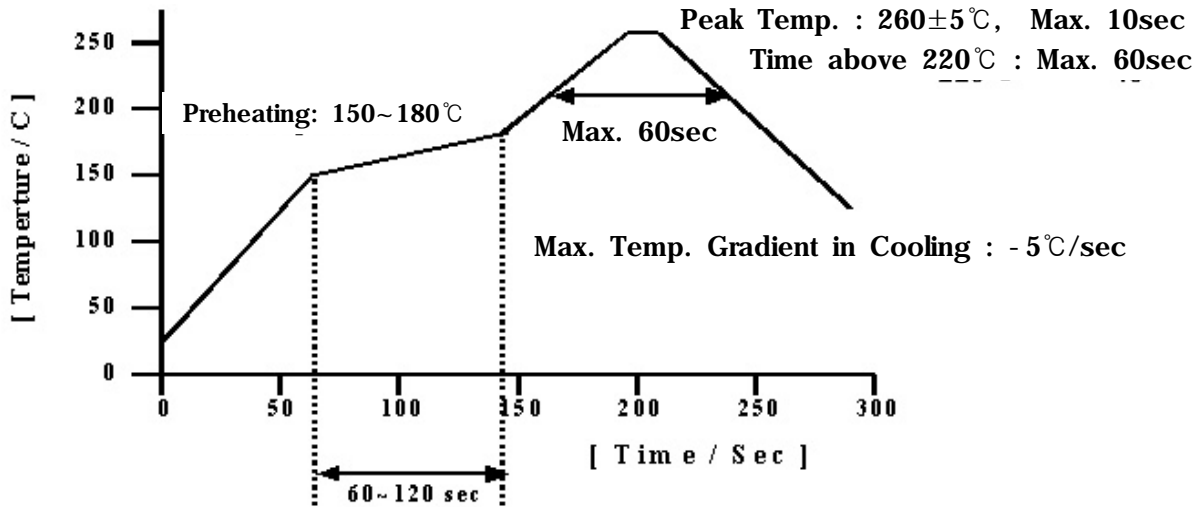
2) Criteria for Judging the Damage

Item	Symbol	Test Condition	Limit	
			Min	Max
Forward Voltage	VF	IF = 700 mA	-	U.S.L.*1.2
Luminous Flux	Φv	IF = 700 mA	L.S.L.*0.5	-

* USL : Upper Standard Level LSL : Lower Standard Level

■ Solder Conditions

Reflow Frequency : 2 times max.



2) For Manual Soldering

Not more than 5 seconds @MAX 300°C , under soldering iron.

■ Taping Dimension

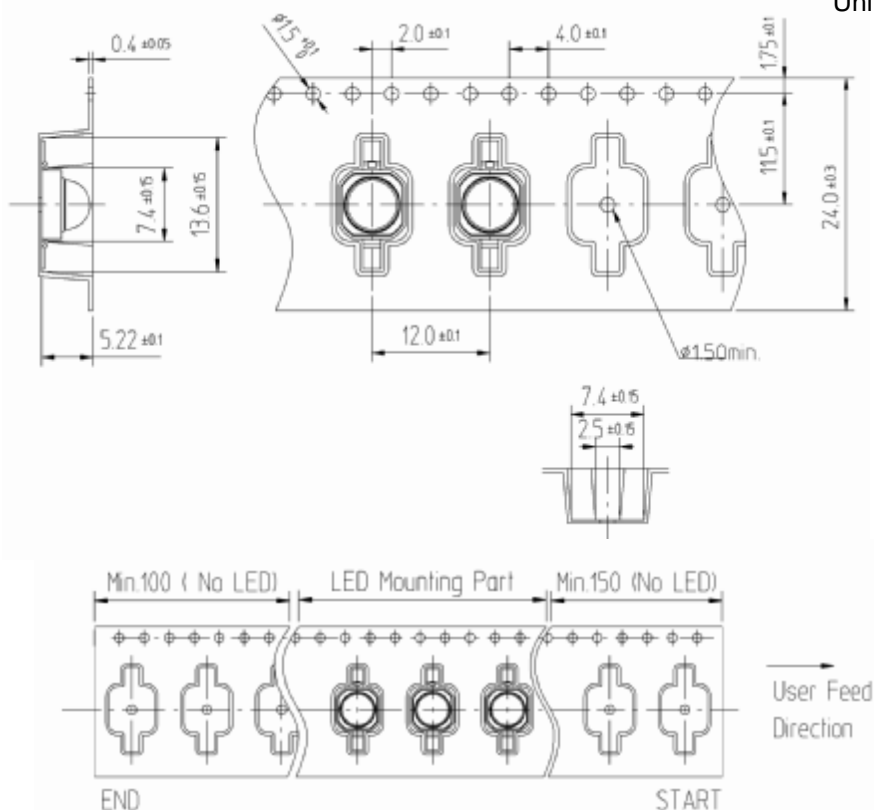
Unit : mm

1. Carrier Tape

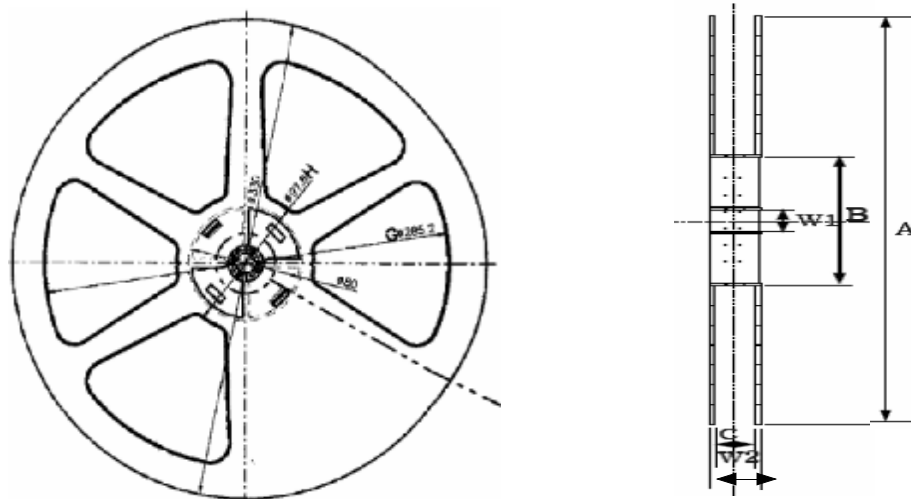
Cathode



Anode



2. Reel



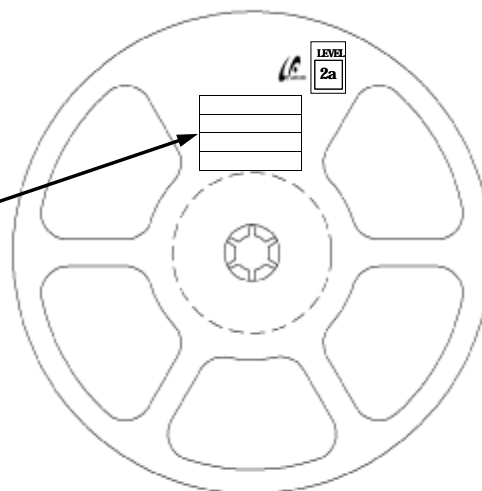
Symbol	A	B	C	W1	W2
Dimension(mm)	330 ± 1	80 ± 1	25 ± 0.5	13 ± 0.3	29.5 ± 1

- (1) Quantity : 1,000 Pcs / 13" Reel.
- (2) Cumulative Tolerance : Cumulative Tolerance/10 pitches to be $\pm 0.2\text{mm}$
- (3) Adhesion Strength of Cover Tape : Adhesion strength to be 0.1-0.7N when the cover tape is turned off from the carrier tape at 10°C angle to be the carrier tape.
- (4) Packaging : P/N, Manufacturing data Code No. and quantity to be indicated on a damp proof Package

Reel Packing Structure

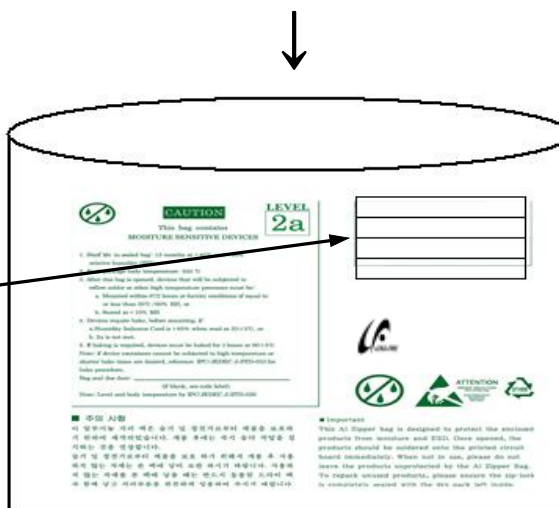
1) Reel

S0R0G2
 SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxx / xxxx / xxxxpcs
 |||



2) Aluminum Vinyl Bag

S0R0G2
 SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxx / xxxx / xxxxpcs
 |||

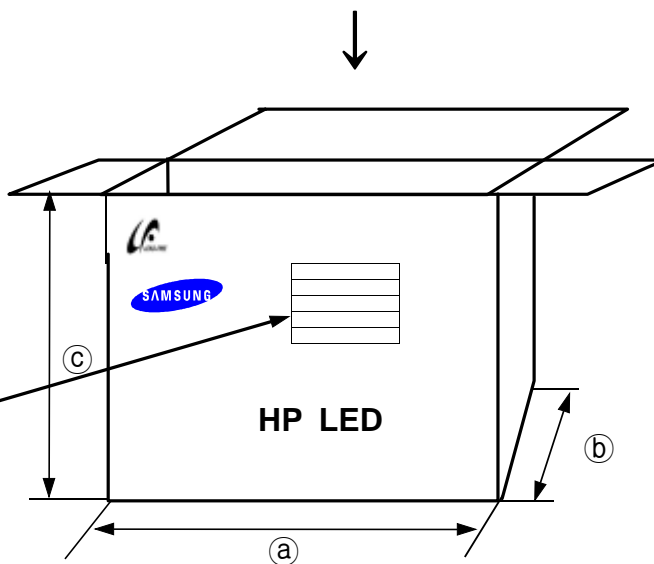


3) Inner Box

Material : Paper(SW3B(B))

TYPE	SIZE(mm)		
	a	b	c
13inch	335	45	335

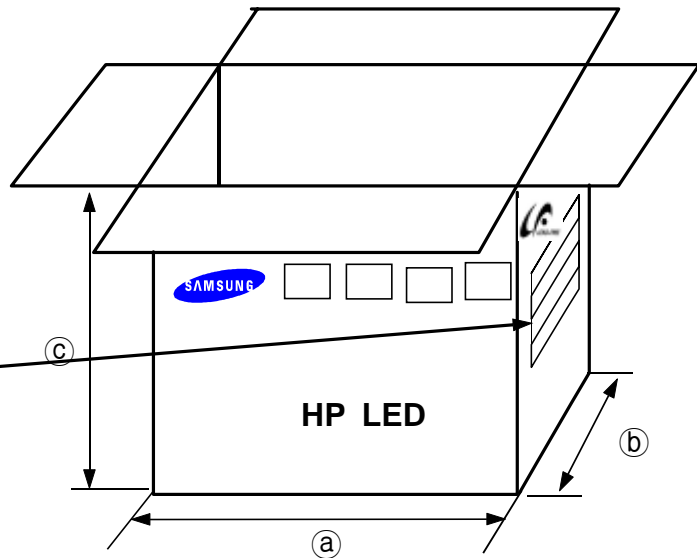
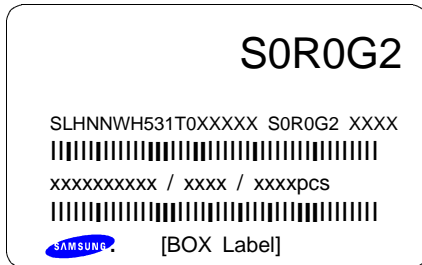
S0R0G2
 SLHNNWH531T0XXXXX S0R0G2 XXXX
 |||
 xxxxxxxxxxx / xxxx / xxxxpcs
 |||



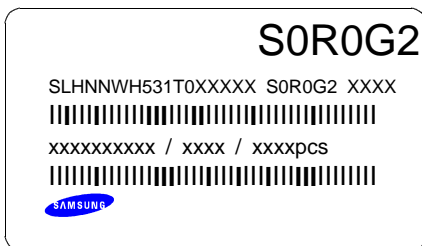
4) Carton Box

Material : Paper(SW3B(B))

TYPE	SIZE(mm)		
	(a)	(b)	(c)
13inch	350	350	350



Label Structure



(S0): VF Rank

(R0): Chromaticity Coordinate Rank(CCT)

(G2): Luminous Flux

Lot Number

The Lot number is composed of the following characters

●◎◇◆□■△△△ / I▲▲▲ / 1000PCS

● : Production Site (S:SEMCO, G:Gosin China)

◎ : L (LED)

◇ : Product State (A:Normality, B: Bulk, C:First Production, R:reproduction, S:Sample)


◆ : Year (Q:2006, R:2007, S:2008...)

□ : Month (1 ~ 9, A, B, C)

■ : Day (1 ~ 9, A, B ~ V)

△ : SEMCo. Product number (1 ~ 999)

▲ : Reel Number (1 ~ 999)



CAUTION

This bag contains
MOISTURE SENSITIVE DEVICES

LEVEL 2a

1. Shelf life in sealed bag: 12 months at <math>< 40^{\circ}\text{C}</math> and <math>< 90\%</math> relative humidity (RH)
2. Peak package body temperature: 240°C
3. After this bag is opened, devices that will be subjected to reflow solder or other high temperature processes must be:
 - a. Mounted within 672 hours at factory conditions of equal to or less than 30°C / 60% RH, or
 - b. Stored at <math>< 10\%</math> RH
4. Devices require bake, before mounting, if:
 - a. Humidity Indicator Card is > 65% when read at $23 \pm 5^{\circ}\text{C}$, or
 - b. 2a is not met.
5. If baking is required, devices must be baked for 1 hours at $60 \pm 5^{\circ}\text{C}$


Note: if device containers cannot be subjected to high temperature or shorter bake times are desired, reference IPC/JEDEC J-STD-033 for bake procedure.

Bag seal due date: _____
(if blank, see code label)

Note: Level and body temperature by IPC/JEDEC J-STD-020

S0R0G2

SLHNNWH531T0XXXXX S0R0G2 XXXX
 XXXXXXXXXXXX / XXXX / XXXXPCS




■ 주의 사항

이 알루미늄 지퍼 팩은 습기 및 정전기로부터 제품을 보호하기 위하여 제작되었습니다. 개봉 후에는 즉시 솔더 작업을 실시하는 것을 권장합니다.

습기 및 정전기로부터 제품을 보호 하기 위해서 개봉 후 사용하지 않는 자재는 본 팩에 넣어 보관 하시기 바랍니다. 사용하지 않는 자재를 본 팩에 넣을 때는 반드시 동봉된 드라이 팩과 함께 넣고 지퍼부분을 완전히 밀봉하여 주시기 바랍니다.

■ Important

This Al Zipper bag is designed to protect the enclosed products from moisture and ESD. Once opened, the products should be soldered onto the printed circuit board immediately. When not in use, please do not leave the products unprotected by the Al Zipper Bag. To repack unused products, please ensure the zip-lock is completely sealed with the dry pack left inside.

Silical gel & Humidity Indicator Card in Aluminum Vinyl Bag



■ Precaution for Use

- 1) For over-current-proof function, customers are recommended to apply resistors to prevent sudden change of the current caused by slight shift of the voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When washing is required, IPA is recommended to use.
- 3) When the LEDs illuminate, operating current should be decided after considering the ambient maximum temperature.
- 4) LEDs must be stored in a clean environment.
If the LEDs are to be stored for 3 months or more after being shipped from SEMCO, they should be packed by a sealed container with nitrogen gas injected. (Shelf life of sealed bags : 12 months, temp. 0~40°C, 20~70%RH)
- 5) After storage bag is open, device subjected to soldering, solder reflow, or other high temperature processes must be:
 - a. Mounted within 168 hours (7 days) at an assembly line with a condition of no more than 30°C/60%RH,
 - b. Stored at <10% RH.
- 6) Repack unused Products with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading is >65% at 23±5°C.
- 8) Devices must be baked for 24hours at 65±5°C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs.

If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices.

Damaged LEDs may show some unusual characteristics such as increase in leak current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.



Test Report No. F690501/LF-CTSAYA08-04156

Issued Date: February 11, 2008 Page 2 of 3

Sample No. : AYA08-04156.001
 Sample Description : LED
 Item No./Part No. : 7070 Lens (Cool White)

Heavy Metals

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	0.5	N.D.
Lead (Pb)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	5	N.D.
Mercury (Hg)	mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP	2	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	US EPA 3060A(1996), US EPA 7196A(1992), UV	1	N.D.

Flame Retardants-PBBs/PBDEs

Test Items	Unit	Test Method	MDL	Results
Monobromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Monobromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.

- NOTE: (1) N.D. = Not detected.(<MDL)
 (2) mg/kg = ppm
 (3) MDL = Method Detection Limit
 (4) - = No regulation
 (5) ** = Qualitative analysis (No Unit)
 (6) Negative = Undetectable / Positive = Detectable

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